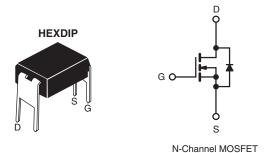


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	60			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	0.10		
Q _g (Max.) (nC)	25			
Q _{gs} (nC)	5.8			
Q _{gd} (nC)	11			
Configuration	Single			



FEATURES

- Dynamic dV/dt Rating
- · For Automatic Insertion
- End Stackable
- 175 °C Operating Temperature
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W

ORDERING INFORMATION	
Package	HEXDIP
Load (Dh) from	IRFD024PbF
Lead (Pb)-free	SiHFD024-E3
SnPb	IRFD024
SILD	SiHFD024

ABSOLUTE MAXIMUM RATINGS $T_C = 25$ °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	60	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V _{GS} at 10 V	T _A = 25 °C	- I _D	2.5	А	
		T _A = 100 °C		1.8		
Pulsed Drain Current ^a			I _{DM}	20		
Linear Derating Factor				0.0083	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	91	mJ	
Maximum Power Dissipation	T _A = 25 °C		P_D	1.3	W	
Peak Diode Recovery dV/dt ^c			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 16 mH, R_G = 25 Ω , I_{AS} = 2.5 A (see fig. 12).
- c. $I_{SD} \leq$ 17 A, $dI/dt \leq$ 140 A/µs, $V_{DD} \leq V_{DS}, \, T_J \leq$ 175 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFD024, SiHFD024

Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R_{thJA}	=	120	°C/W	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static					•	•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	60	-	-	٧	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = 1 mA		0.061	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V		-	± 100	nA
Zone Ooto Vallana Busin Oursel		V _{DS} = 60 V, V _{GS} = 0 V		-	-	25	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 48 V	V _{DS} = 48 V, V _{GS} = 0 V, T _J = 150 °C		-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 1.5 A ^b	-	-	0.10	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	V _{DS} = 25 V, I _D = 1.5 A ^b		-	-	S
Dynamic							
Input Capacitance	C _{iss}	V _{GS} = 0 V,		-	640	-	pF
Output Capacitance	C _{oss}]	$V_{DS} = 25 \text{ V},$		360	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	79	-	
Total Gate Charge	Qg			-	-	25	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 17 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 ^b	-	-	5.8	
Gate-Drain Charge	Q _{gd}	see lig. 0 and 10		-	11		
Turn-On Delay Time	t _{d(on)}	V_{DD} = 30 V, I_D = 17 A, R_G = 18 Ω , R_D = 1.7 Ω , see fig. 10 ^b		-	13	-	- ns
Rise Time	t _r			-	58	-	
Turn-Off Delay Time	t _{d(off)}			-	25	-	
Fall Time	t _f			-	42	-	
Internal Drain Inductance	L_{D}	6 mm (0.25")	Between lead, 6 mm (0.25") from		4.0	-	nH
Internal Source Inductance	L _S	package and center of die contact		-	6.0	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.5	Α
Pulsed Diode Forward Current ^a	I _{SM}			-	-	20	
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 2.5 A, V _{GS} = 0 V ^b		-	-	1.5	٧
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 17 A, dI/dt = 100 A/μs ^b		-	80	180	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.29	0.64	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_Γ				L _D)	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

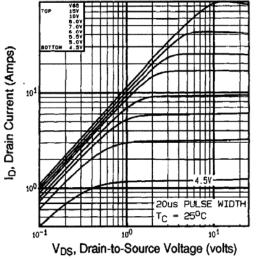
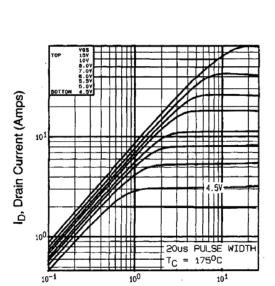


Fig. 1 - Typical Output Characteristics, T_C = 25 °C



 V_{DS} , Drain-to-Source Voltage (volts) Fig. 2 - Typical Output Characteristics, T_C = 175 °C

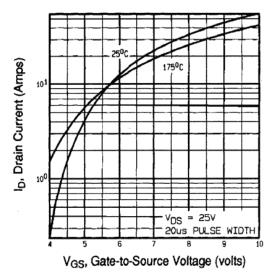


Fig. 3 - Typical Transfer Characteristics

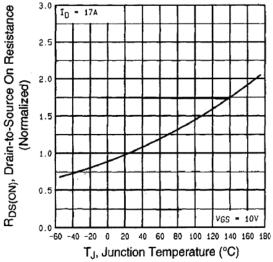


Fig. 4 - Normalized On-Resistance vs. Temperature

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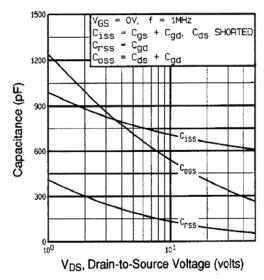


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

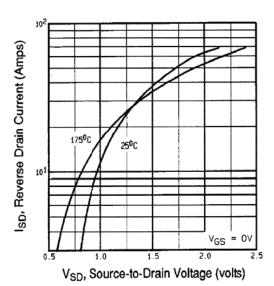


Fig. 7 - Typical Source-Drain Diode Forward Voltage

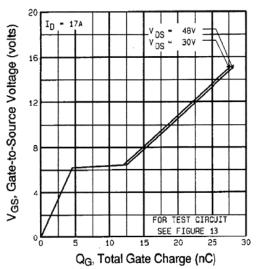
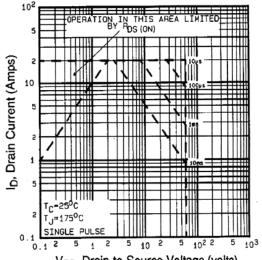


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



V_{DS}, Drain-to-Source Voltage (volts) Fig. 8 - Maximum Safe Operating Area





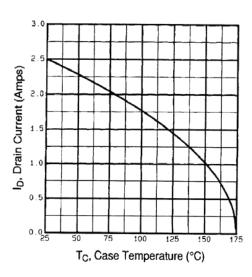


Fig. 9 - Maximum Drain Current vs. Case Temperature

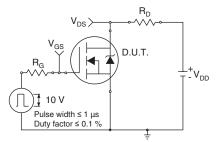


Fig. 10a - Switching Time Test Circuit

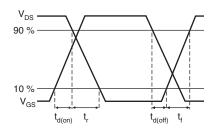


Fig. 10b - Switching Time Waveforms

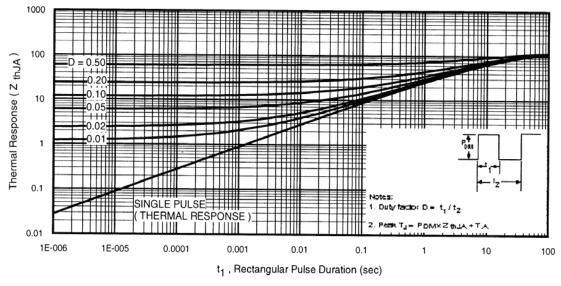


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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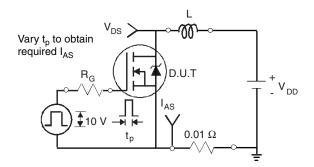


Fig. 12a - Unclamped Inductive Test Circuit

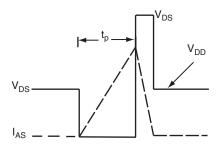


Fig. 12b - Unclamped Inductive Waveforms

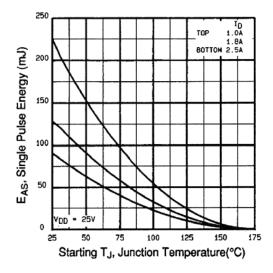


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

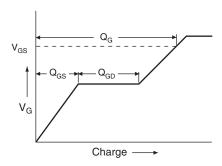


Fig. 13a - Basic Gate Charge Waveform

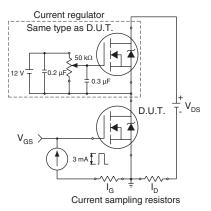
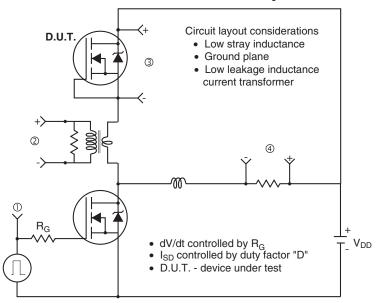
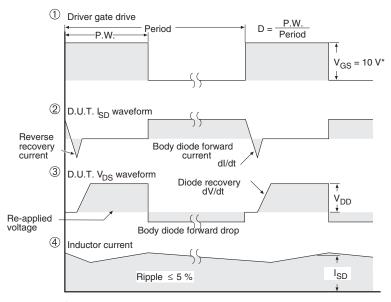


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* V_{GS} = 5 V for logic level and 3 V drive devices

Fig. 14 - For N-Channel

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Revision: 18-Jul-08

Document Number: 91000 www.vishay.com